

Specification Sheet

<Chip Monolithic Ceramic Capacitor>

Murata Global P/N : GRM155R60J106ME44D (0402,X5R,10μF,6.3V)

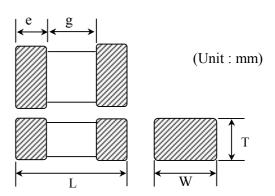
Corresponding products for RoHS directive

1.Dimensions (Unit:mm)

	· ,
L	1.0+/-0.2
W	0.5+/-0.2
T	0.5+/-0.2
e	0.15 to 0.35
g	0.3min.

2 Rated Value

Rated value							
TC code	R6 X5R						
TC							
Temp.Coeff or Cap.Change	+/-15% at -55 to 85°C						
CAP. , CAP.TOL	10 μF, +/-20%						
DC Rated Voltage	6.3V						
Size Code	0402						



3. Packaging

Specification	Packaging unit [pcs/reel]				
φ180 Paper Tape Carrier Packaging	10000				

4. Specification

Please refer to next page.

△Note

- (1) This specification sheet is applied for CHIP MONOLITHIC CERAMIC CAPACITOR used for General Electronics equipment for your design.
- (2) Please contact our sales representative or product engineers before using our products for the application listed below.
 - ① Aircraft equipment ② Aerospace equipment ③ Undersea equipment ④ Medical equipment
 - $\begin{tabular}{ll} \hline \begin{tabular}{ll} \hline \end{tabular} \hline \end{tabular} \hline \begin{tabular}{ll} \hline \end{tabular} \hline$
 - Application of similar complexity and/or requirements to the applications listed in the above.
- (3) Solderability of Tin plating termination chip might be deteriorated when low temperature soldering profile where peak solder temperature is below the Tin melting point is used. Please confirm the solderability of Tin plating termination chip before use.
- (4)Use of Sn-Zn based solder will deteriorate reliability of MLCC. Please contact murata factory for the use of Sn-Zn based solder in advance.
- (5) This specification sheet has only typical specification because there is no space for detailed specifications.
 - Therefore, please approve our product specification or transact the approval sheet for product specification before your ordering. Especially, please read rating and CAUTION (for storage, operating, rating, soldering, mounting, and handling) in them to prevent smoking and /or burning, etc.
- (6)You are able to read a detailed specification of our some products listed in this specification sheet in the web-site of MURATA (http://www.murata.com/) before to require our product specification or to transact the approval sheet.
- (7)Product specifications are subject to change without advance notice.

Please check with our sales representatives or product engineers before ordering.

If there are any questions, please contact our sales representatives or product engineers.

Business Development Support Sec. I Planning & Market Promotion Department

■ SPECIFICATIONS AND TEST METHODS

No.	Item	Specification					Test Method					
	7.7	Specification R6: -55°C to +85°C										
	Temperature Range	R6: -55°C to +85°C R7/ C7/ E7/ D7: -55°C to +125°C F5: -30°C to +85°C C8: -55°C to +105°C					Reference Temperature : 25°C					
2	Rated Voltage	See the previous pages				The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V ^{P-P} or V ^{O-P} , whichever is larger, should be maintained within the rated voltage range.						
3	Appearance	No defects or a	abnormalities			Visua	l inspection.					
		Within the spe					calipers or Micr				• •	
	Dielectric Strength					No failure should be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.						
	Resistance	More than 50Ω				The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25°C and 75%RH max. and within 1 minutes of charging.						
	·	Within the spe					oltage shown	in the table	•		he frequency	
8		R6 / R7 / C7/ C8/ E7 /D7 : 0.1 max. F5 : 0.2 max.					Capacit C≦10μF (1 C≦10μF (6 C > 10	0V min.) .3V max.)	Frequency 1 ± 0.1 kHz 1 ± 0.1 kHz 120 ± 24 Hz	* 1.0 ±	oltage 0.2 Vrms 0.1 Vrms 0.1 Vrms	
						* Measuring Voltage: 0.5±0.1Vrms GRM155R61A124 to 105, GRM022R61A103 GRM185R61A/1C105,GRM188R61A/1C225 GRM188C8/D71A225,GRM188R71A225 GRM188R61A335, GRM219R61A106/475, GRM219R61C475 GRM21BR6/R71A/1C106, GRM319R61A/1C106 7.Capacitance GRM033 R6 0G/0J 105 Perform a heat treatment at 150 +0/-10°C for one hour and then set for 24±2 hours at room temprature						
9	Capacitance			Reference		The c	apacitance cl	nange shoul		red after 5 m	nin.at each	
	Temperature Characteristics	R6 -55°C R7 -55°C F5 -30° C7 -55°C C8 -55°C D7 -55°C	C to +85°C C to +85°C C to +85°C C to +125°C C to +125°C C to +125°C C to +105°C C to +125°C C to +125°C	Temp. 25°C 25°C 25°C 25°C 25°C 25°C 25°C		specified temperature stage. The ranges of capacitance change compared with the 25°C value over the temperature ranges shown in the table shall be within the specified ranges. Measuring Voltage: GRM43 R6 0J/1A 336/476: 1.0+/-0.2Vrms GRM033 R6 0J 474, GRM155 R6 0J 475, GRM153 R6 0G/0J 226 GRM155 R6 0G 106, GRM188 R6 0G/0J 226, GRM219 R6 1A 22						
	_	occur.	the termination of the terminati	c c	<i>a</i>	using test ji using solde	a eutectic so g for 10±1 se	lder. Then a c. The solde ethod and sl n and free of	pply 10N* foring should hould be confided be confided be confided by the confi	orce in para be done eith nducted with	er with an iron or care so that the	
11		Appearance No defects or abnormalities Capacitance Within the specified tolerance D.F R6/R7/C7/C8/E7/D7: 0.1 max.				Solder the capacitor on the test jig (glass epoxy board) in the same manner and under the same conditions as (10). The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute.						
	F5: 0.2 max. This motion sho						notion should ually perpend	be applied licular direct	for a period ions (total of	of 2 hours ir f 6 hours).	ı each	

■ SPECIFICATIONS AND TEST METHODS

No		101107111	Specification			Toot !	Method		ГД		
	Item Deflection	Appearance	Specification No defects or abnormalities	Solder	the canacit	or to the test jig (oxy hoard) sho	wn in Fig 2		
'-	Deficetion	Appearance INO detects or abnormalities			a eutectic so	older. Then apply	a force i	n the direction	shown in		
		Capacitance	Within ±10%	using a eutectic solder. Then apply a force in the direction shown in Fig.3. The soldering should be done by the reflow method and should							
		Change		be conducted with care so that the soldering is uniform and free or defects such as heat shock.							
						Туре	а	b	С		
		20	50 Pressunzing	ļ		GRM02	0.2	0.56	0.23		
			speed:1.0mm/sec.		94.5 •	GR□03	0.3	0.9	0.3		
		R230	Pressunze	⊸ á	40	GR□15	0.4	1.5	0.5		
						GRM18	1.0	3.0	1.2		
			Flexure: ≦1		→	GRM21	1.2	4.0	1.65		
		Capacit	tance meter Fig.2	_		GRM31	2.2	5.0	2.0		
		45	45 CDM02 CDE02/45 + 4 + 0.2 mm			GRM32 GRM43	2.2 3.5	5.0 7.0	3.7		
		Fig	GRM02, GR□03/15: t:0.8mm t:1.6mm			GRM55	4.5	8.0	5.6		
			,·-			0.100		0.0	(in:mm)		
13	Solderability	75% of the ter	minations is to be soldered evenly	Imme	se the capa	citor in a solution	of ethan	ol (JIS-K-8101) and rosin		
	of Termination	and continuously			(JIS-K-5902) (25% rosin in weight proportion). Preheat at 80 to 120°C for 10 to 30 seconds. After preheating, immerse in eutectic solder						
						•	•				
				solution for 2±0.5 seconds at 230±5°C or Sn-3.0 Ag-0.5 Cu solder solution for 2±0.5 seconds at 245±5°C.							
14	Resistance	Appearance	No defects or abnormalities	_		citor at 120 to		or 1 minute.	Immerse the		
	to Soldering Heat	Capacitance	R6/R7/C7/C8/E7/D7: Within ±15%	capacitor in an eutectic solder solution* or Sn-3.0 Ag-0.5 Cu solder							
		Change	F5: Within ±20%		et at room ter	mperature for					
		D.F.	R6/R7/C7/C8/E7/D7: 0.1 max.		nours, then rapply to GRN						
		I D	F5: 0.2 max.	· Initia	l measureme	ent for high dieled					
		I.R.	More than 50Ω· F			eatment at 150+0	/-10°C fc	or one hour ar	nd then set at		
		Dielectric	No defects		room temperature for 24±2 hours. Perform the initial measurement.						
		Strength			eating for G						
					Step	Temper	ature	Tir	me		
					1	100°C to	120°C	1m	nin.		
					2	170°C to	200°C	1m	nin.		
15	Temperature	Appearance	No defects or abnormalities	Fix the	e capacitor to	the supporting j	ig in the s	same manner	and under		
	Sudden	Capacitance	R6/R7/C7/C8/D7: Within ±7.5%	the sa	me condition	ns as (10). Perfor	m the five	e cycles accor			
	Change	Change	E7: Within ±30%								
		D.F.	F5: Within ±20% R6/R7/C7/C8/E7/D7: 0.1 max.	361 10	Step	1	2 3 4				
		D.1 .	F5 : 0.2 max.		Step	Min.		Max.			
		I.R.	More than 50Ω· F		Temp.(°C)	Operating	Room	Operating	Room		
						Temp.+0/-3	Temp.	Temp.+3/-0	Temp.		
		Dielectric	No defects	1	Time(min.) 30±3	2 to 3	30±3	2 to 3		
		Strength		· Initial measurement for high dielectric constant type							
						atment at 150+0/		one hour and	then set		
				at room temperature for 24±2 hours. Perform the initial measurement.							
16	High	Appearance	No defects or abnormalities			oltage at 40±2°C	and 90 to	o 95% humidi	ty for 500±12		
	Temperature High	Capacitance	R6/R7/C7/C8/E7/D7: Within ±12.5%	hours.	hours.				-		
l		Change F5 Within ±30%				The charge/discharge current is less than 50mA. Initial measurement					
	Humidity (Steady)	D.F.	R6/R7/C7/C8/E7/D7: 0.2max.				′-10°C fo	r one hour and	then set for		
	37	F5: 0.4max.			Perform a heat treatment at 150+0/-10°C for one hour and then set for 24±2 hours at room temperature. Perform the initial measurement. Measurement offer test						
		I.R. More than 12.5Ω· F		 Measurement after test Perform a heat treatment at 150+0/-10°C for one hour and then set for 							
					24±2 hours at room temperature, then measure.						
17	Durability	Appearance	No defects or abnormalities			e rated voltage f					
		Caracitanas D0/D7/07/00/E7/D7 14/1/1 140 70/			operating temperature ±3°C. Set for 24±2 hours at room temperature,						
		Capacitance R6/R7/C7/C8/E7/D7: Within $\pm 12.5\%$ F5: Within $\pm 30\%$				then measure. The charge/ discharge current is less than 50mA.					
		D.F.	R6/R7/C7/C8 /E7/D7: 0.2max.	Inte charge, discharge current is less than some. Initial measurement							
		F5: 0.4max.				Perform a heat treatment at 150+0/-10°C for one hour and then set for					
		I.R.	More than $25\Omega \cdot F$	24±2 hours at room temperature. Perform the initial measurement. · Measurement after test Perform a heat treatment at 150+0/-10°C for one hour and then set for 24±2 hours at room temperature, then measure.							
			•								